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- Qualified for Automotive Applications
- Output Swing Includes Both Supply Rails
- Low Noise . . . 9 nV/√Hz Typ at f = 1 kHz
- Low Input Bias Current . . . 1 pA Typ
- Fully Specified for Both Single-Supply and Split-Supply Operation
- Common-Mode Input Voltage Range Includes Negative Rail

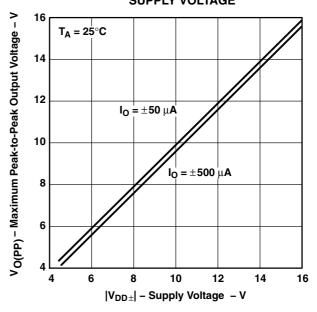
- High-Gain Bandwidth . . . 2.2 MHz Typ
- High Slew Rate . . . 3.6 V/μs Typ
- Low Input Offset Voltage
 950 μV Max at T_Δ = 25°C
- Macromodel Included
- Performance Upgrades for the TS272, TS274, TLC272, and TLC274

description

The TLC2272 and TLC2274 are dual and quadruple operational amplifiers from Texas Instruments. Both devices exhibit rail-to-rail output performance for increased dynamic range in single- or split-supply applications. The TLC227x family offers 2 MHz of bandwidth and 3 V/ μ s of slew rate for higher speed applications. These devices offer comparable ac performance while having better noise, input offset voltage, and power dissipation than existing CMOS operational amplifiers. The TLC227x has a noise voltage of 9 nV/ \sqrt{Hz} , two times lower than competitive solutions.

The TLC227x, exhibiting high input impedance and low noise, is excellent for small-signal conditioning for high-impedance sources, such as piezoelectric transducers. Because of the micropower dissipation levels, these devices work well in hand-held monitoring and remote-sensing applications. In addition, the rail-to-rail output feature, with single- or split-supplies, makes this family a great choice when interfacing with

MAXIMUM PEAK-TO-PEAK OUTPUT VOLTAGE vs SUPPLY VOLTAGE



analog-to-digital converters (ADCs). For precision applications, the TLC227xA family is available with a maximum input offset voltage of 950 μ V. This family is fully characterized at 5 V and \pm 5 V.

The TLC2272/4 also makes great upgrades to the TLC272/4 or TS272/4 in standard designs. They offer increased output dynamic range, lower noise voltage, and lower input offset voltage. This enhanced feature set allows them to be used in a wider range of applications. For applications that require higher output drive and wider input voltage range, see the TLV2432 and TLV2442 devices.



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

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TLC227x-Q1, TLC227xA-Q1 Advanced LinCMOS™ RAIL-TO-RAIL OPERATIONAL AMPLIFIERS

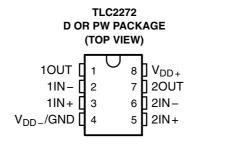
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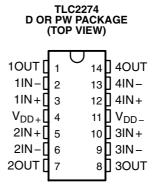
AVAILABLE OPTIONS[†]

	V	PACKAGE	D DEVICES [‡]
T _A	V _{IO} max At	SMALL OUTLINE	TSSOP
	25°C	(D)	(PW)
-40°C to 125°C	950 μV	TLC2272AQDRQ1	TLC2272AQPWRQ1
	2.5 mV	TLC2272QDRQ1	TLC2272QPWRQ1
-40°C to 125°C	950 μV	TLC2274AQDRQ1	TLC2274AQPWRQ1
	2.5 mV	TLC2274QDRQ1	TLC2274QPWRQ1

[†] For the most current package and ordering information, see the Package Option Addendum at the end of this document, or see the TI web site at http://www.ti.com.

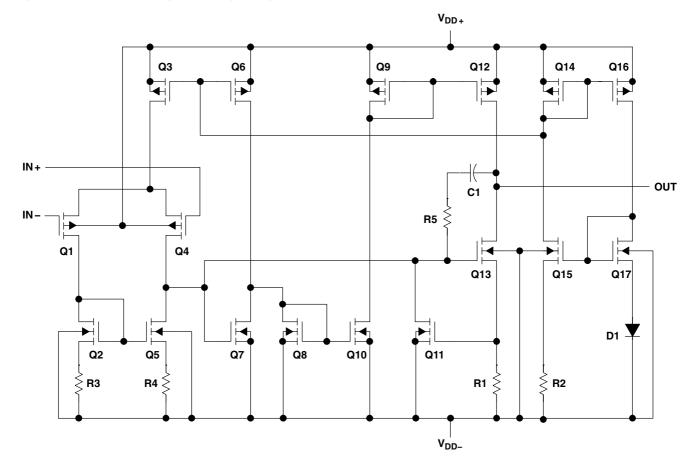
[‡] Package drawings, thermal data, and symbolization are available at http://www.ti.com/packaging.







equivalent schematic (each amplifier)



ACTUAL DEVICE COMPONENT COUNT [†]											
COMPONENT TLC2272 TLC2274											
38	76										
26	52										
9	18										
Capacitors 3 6											
	TLC2272 38										

[†] Includes both amplifiers and all ESD, bias, and trim circuitry

TLC227x-Q1, TLC227xA-Q1 Advanced LinCMOS™ RAIL-TO-RAIL OPERATIONAL AMPLIFIERS

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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage, V _{DD+} (see Note 1)	8 V
Supply voltage, V _{DD} (see Note 1)	8 V
Differential input voltage, V _{ID} (see Note 2)	±16 V
Input voltage range, V _I (any input, see Note 1) V	$_{\rm DD-}$ – 0.3 V to $\rm V_{\rm DD+}$
Input current, I _I (any input)	±5 mA
Output current, I _O	±50 mA
Total current into V _{DD+}	±50 mA
Total current out of V _{DD}	±50 mA
Duration of short-circuit current at (or below) 25°C (see Note 3)	unlimited
Continuous total dissipation See Dissi	ipation Rating Table
Operating free-air temperature range, T _A	40°C to 125°C
Storage temperature range	65°C to 150°C
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds: D or PW package	260°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. All voltage values, except differential voltages, are with respect to the midpoint between V_{DD+} and V_{DD-} .

- 2. Differential voltages are at IN+ with respect to IN -. Excessive current will flow if input is brought below V_{DD} 0.3 V.
- 3. The output may be shorted to either supply. Temperature and/or supply voltages must be limited to ensure that the maximum dissipation rating is not exceeded.

DISSIPATION RATING TABLE

PACKAGE	$T_A \le 25^{\circ}C$ POWER RATING	DERATING FACTOR ABOVE T _A = 25°C	T _A = 70°C POWER RATING	T _A = 85°C POWER RATING	T _A = 125°C POWER RATING
D-8	725 mW	5.8 mW/°C	464 mW	337 mW	145 mW
D-14	950 mW	7.6 mW/°C	608 mW	494 mW	190 mW
PW-8	525 mW	4.2 mW/°C	336 mW	273 mW	105 mW
PW-14	700 mW	5.6 mW/°C	448 mW	364 mW	_

ELECTROSTATIC DISCHARGE RATING TABLE

				RATING
			Human-Body Model (HBM)	2000 V
	TLC2272	Machine Model (MM)	100 V	
F0D	Electron Action Back and a control		Charged-Device Model (CDM)	1500 V
ESD	Electrostatic discharge rating		Human-Body Model (HBM)	500 V
		TLC2274	Machine Model (MM)	100 V
			Charged-Device Model (CDM)	1000 V

recommended operating conditions

		MIN	MAX	UNIT
$V_{DD\pm}$	Supply voltage	±2.2	±8	V
VI	Input voltage	V_{DD-}	V _{DD+} –1.5	V
V _{IC}	Common-mode input voltage	V_{DD-}	V _{DD+} –1.5	٧
T _A	Operating free-air temperature	-40	125	°C



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TLC2272Q electrical characteristics at specified free-air temperature, V_{DD} = 5 V (unless otherwise noted)

	PARAMETER	TEST CO	NDITIONS	- +	Т	LC2272	Q	TL	.C2272A	.Q	LINIT	
	PARAMETER	l lesi co	NDITIONS	T _A †	MIN	TYP	MAX	MIN	TYP	MAX	UNIT	
V	Input offset voltage			25°C		300	2500		300	950	μV	
V_{IO}	input onset voltage			Full range			3000			1500	μV	
α_{VIO}	Temperature coefficient of input offset voltage			25°C to 125°C		2			2		μV/°C	
	Input offset voltage long- term drift (see Note 4)	$V_{IC} = 0 V,$ $V_{O} = 0 V,$	$V_{DD\pm} = \pm 2.5 \text{ V},$ $R_S = 50 \Omega$	25°C		0.002			0.002		μV/mo	
L	Input offset current	1		25°C		0.5	60		0.5	60	рA	
I _{IO}	input onset current			Full range			800			800	pΑ	
I _{IB}	Input bias current			25°C		1	60		1	60	рA	
פוי	input blue ourrent			Full range			800			800	P	
V_{ICR}	Common-mode input	$R_S = 50 \Omega$	$ V_{IO} \le 5 \text{ mV}$	25°C	0 to 4	-0.3 to 4.2		0 to 4	-0.3 to 4.2		V	
VICR	voltage	ns = 50 12,	v 0 ≥ 3 111v	Full range	0 to 3.5			0 to 3.5			V	
		$I_{OH} = -20 \mu A$		25°C		4.99			4.99			
	LCab laval avdavd	J 000 A		25°C	4.85	4.93		4.85	4.93			
V_{OH}	High-level output voltage	$I_{OH} = -200 \mu\text{A}$		Full range	4.85			4.85			V	
	vollago	I _{OH} = -1 mA		25°C	4.25	4.65		4.25	4.65			
		IOH = - I IIIA		Full range	4.25			4.25				
		$V_{IC} = 2.5 V$,	$I_{OL} = 50 \mu\text{A}$	25°C		0.01			0.01			
		V _{IC} = 2.5 V,	$I_{OL} = 500 \mu\text{A}$	25°C		0.09	0.15		0.09	0.15		
V_{OL}	Low-level output voltage	V ₁ C = 2.5 V,	-10L = 000 μ/τ	Full range			0.15			0.15	V	
		V _{IC} = 2.5 V,	I _{OL} = 5 mA	25°C		0.9	1.5		0.9	1.5		
		10 =:0 1,	.00	Full range			1.5			1.5		
	Large-signal	V _{IC} = 2.5 V,	$R_L = 10 \text{ k}\Omega^{\ddagger}$	25°C	10	35		10	35			
A_{VD}	differential voltage	$V_0 = 1 \text{ V to 4 V}$		Full range	10			10			V/mV	
	amplification	Ŭ	$R_L = 1 \text{ m}\Omega^{\ddagger}$	25°C		175			175			
r _{id}	Differential input resistance			25°C		10 ¹²			10 ¹²		Ω	
rį	Common-mode input resistance			25°C		10 ¹²			10 ¹²		Ω	
c _i	Common-mode input capacitance	f = 10 kHz,	P package	25°C		8			8		pF	
z _o	Closed-loop output impedance	f = 1 MHz,	A _V = 10	25°C		140			140		Ω	
CMDD	Common-mode rejection	$V_{IC} = 0 \text{ V to } 2.7 \text{ V}$	V,	25°C	70	75		70	75		40	
CMRR	ratio	$V_0 = 2.5 \text{ V},$	$R_S = 50 \Omega$	Full range	70			70			dB	
ka=	Supply-voltage rejection	$V_{DD} = 4.4 \text{ V to 1}$	/ _{DD} = 4.4 V to 16 V,		80	95		80	95		40	
k _{SVR}	ratio $(\Delta V_{DD}/\Delta V_{IO})$	$V_{IC} = V_{DD}/2$,	No load	Full range	80			80			dB	
I	Cumply ourrant	V 2 F V	No lood	25°C		2.2	3		2.2	3	m A	
I_{DD}	Supply current	$V_{O} = 2.5 \text{ V},$	No load	Full range			3			3	mA	

[†] Full range is -40°C to 125°C for Q level part.

NOTE 4: Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at $T_A = 150^{\circ}C$ extrapolated to $T_A = 25^{\circ}C$ using the Arrhenius equation and assuming an activation energy of 0.96 eV.



[‡] Referenced to 2.5 V

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TLC2272Q operating characteristics at specified free-air temperature, $V_{DD} = 5 \text{ V}$

	DAMETER	TEGT CONDITIO	NIO.		-	TLC22720)	Т	LC2272A	Q	UNIT
PA	ARAMETER	TEST CONDITIO	JNS	T _A †	MIN	TYP	MAX	MIN	TYP	MAX	UNII
		V 4.05.V. 0.75.V		25°C	2.3	3.6		2.3	3.6		
SR	Slew rate at unity gain	V_{O} = 1.25 V to 2.75 V, R_{L} = 10 k Ω^{\ddagger} , C_{L} = 100 pF [‡]		Full range	1.7			1.7			V/μs
.,	Equivalent input	f = 10 Hz		25°C		50			50		nV/√ Hz
V _n	noise voltage	f = 1 kHz		25°C		9			9		nv/√Hz
V	Peak-to-peak	f = 0.1 Hz to 1 Hz		25°C		1			1		
V _{NPP}	equivalent input noise voltage	f = 0.1 Hz to 10 Hz		25°C		1.4			1.4		μV
In	Equivalent input noise current			25°C		0.6			0.6		fA/√ Hz
	Total harmonic	$V_{O} = 0.5 \text{ V to } 2.5 \text{ V},$	A _V = 1			0.0013%			0.0013%		
THD + N	distortion plus	f = 20 kHz,	A _V = 10	25°C		0.004%		0.004%			
	noise	$R_L = 10 \text{ k}\Omega^{\ddagger}$,	$A_V = 100$			0.03%			0.03%		
	Gain-bandwidth product	$f = 10 \text{ kHz}, R_L$ $C_L = 100 \text{ pF}^{\ddagger}$	$= 10 \text{ k}\Omega^{\ddagger},$	25°C		2.18			2.18		MHz
B _{OM}	Maximum output- swing bandwidth		v = 1, = 100 pF [‡]	25°C		1			1		MHz
	Cattling time	$A_V = -1$, Step = 0.5 V to 2.5 V,	To 0.1%	25°C		1.5			1.5		:
t _s	Settling time	$R_L = 10 \text{ k}\Omega^{\ddagger},$ $C_L = 100 \text{ pF}^{\ddagger}$	To 0.01%	25°C		2.6			2.6		μs
φ _m	Phase margin at unity gain	$R_L = 10 \text{ k}\Omega^{\ddagger}, \qquad C_L$	= 100 pF‡	25°C		50°			50°		
	Gain margin]		25°C		10			10		dB

[†] Full range is -40°C to 125°C for Q level part.



[‡] Referenced to 2.5 V

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TLC2272Q electrical characteristics at specified free-air temperature, $V_{DD\pm}$ = ± 5 V (unless otherwise noted)

	PARAMETER	TEST CO	ONDITIONS	- +	TI	LC22720	2	TL	C2272A	Q	
	PANAWIETEN	1231 00	DINDITIONS	T _A †	MIN	TYP	MAX	MIN	TYP	MAX	UNIT
V _{IO}	Input offset voltage			25°C		300	2500		300	950	μV
VIO	Input onset voltage			Full range			3000			1500	μν
α_{VIO}	Temperature coefficient of input offset voltage			25°C to 125°C		2			2		μV/°C
	Input offset voltage long-term drift (see Note 4)	$V_{IC} = 0 V$, $R_S = 50 \Omega$	$V_O = 0 V$,	25°C		0.002			0.002		μV/mo
l. a	Input offset current			25°C		0.5	60		0.5	60	- 24
I _{IO}	input onset current			Full range			800			800	рA
I _{IB}	Input bias current			25°C		1	60		1	60	pА
чв	input bias current			Full range			800			800	рΑ
V _{ICR}	Common-mode input	$R_S = 50 \Omega$	V _{IO} ≤ 5 mV	25°C	-5 to 4	-5.3 to 4.2		-5 to 4	-5.3 to 4.2		v
VICR	voltage	ns = 30 sz,	14101 ≥ 2 111A	Full range	-5 to 3.5			-5 to 3.5			V
		$I_O = -20 \mu A$		25°C		4.99			4.99		
	Marrian una manistir a manis	I _O = -200 μA		25°C	4.85	4.93		4.85	4.93		
V_{OM+}	Maximum positive peak output voltage	10 = -200 μΑ		Full range	4.85			4.85			V
	output voltage	la = _1 mA		25°C	4.25	4.65		4.25	4.65		
		I _O = –1 mA		Full range	4.25			4.25			
		$V_{IC} = 0 V$,	$I_O = 50 \mu\text{A}$	25°C		-4.99			-4.99		
	Maximum negative peak	V _{IC} = 0 V,	I _O = 500 μA	25°C	-4.85	-4.91		-4.85	-4.91		
V_{OM-}	output voltage	V (C = 0 V,	10 = 000 μ/τ	Full range	-4.85			-4.85			V
		$V_{IC} = 0 V$	$I_O = 5 \text{ mA}$	25°C	-3.5	-4.1		-3.5	-4.1		
		V _{IC} = 0 V,	10 = 0 1131	Full range	-3.5			-3.5			
	Large-signal differential		$R_L = 10 \text{ k}\Omega$	25°C	20	50		20	50		
A_{VD}	voltage amplification	$V_O = \pm 4 V$	_	Full range	20			20			V/mV
			$R_L = 1 \text{ m}\Omega$	25°C		300			300		
r _{id}	Differential input resistance			25°C		10 ¹²			10 ¹²		Ω
r _i	Common-mode input resistance			25°C		10 ¹²			10 ¹²		Ω
c _i	Common-mode input capacitance	f = 10 kHz,	P package	25°C		8			8		pF
z _o	Closed-loop output impedance	f = 1 MHz,	A _V = 10	25°C		130			130		Ω
OMBE	Common-mode rejection	$V_{IC} = -5 \text{ V to}$	2.7 V,	25°C	75	80		75	80		45
CMRR	ratio	$V_0 = 0 V$,	$R_S = 50 \Omega$	Full range	75			75			dB
le.	Supply-voltage rejection	V _{DD} = ±2.2 V	′ to ±8 V,	25°C	80	95		80	95		<u> ۲</u>
k _{SVR}	ratio $(\Delta V_{DD\pm}/\Delta V_{IO})$	$V_{IC} = 0 V$	No load	Full range	80			80			dB
	0 1 :	v 6-v		25°C		2.4	3		2.4	3	
I _{DD}	Supply current	$V_0 = 2.5 V$,	No load	Full range			3			3	mA

 $^{^{\}dagger}$ Full range is -40° C to 125 $^{\circ}$ C for Q level part.

NOTE 4: Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at $T_A = 150^{\circ}$ C extrapolated to $T_A = 25^{\circ}$ C using the Arrhenius equation and assuming an activation energy of 0.96 eV.



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TLC2272Q operating characteristics at specified free-air temperature, $V_{DD\pm}$ = $\pm 5~V$

	DAMETER	TEAT COMPLET	0110	- +	7	TLC2272G	!	Т	LC2272A	Q	UNIT
PA	RAMETER	TEST CONDITI	ONS	T _A †	MIN	TYP	MAX	MIN	TYP	MAX	UNII
		., .,,,		25°C	2.3	3.6		2.3	3.6		
SR	Slew rate at unity gain	$V_{O} = \pm 1 \text{ V}, ext{R}_{L} = C_{L} = 100 \text{ pF}$:10 kΩ,	Full range	1.7			1.7			V/μs
.,	Equivalent input	f = 10 Hz		25°C		50			50		nV/√ Hz
V_n	noise voltage	f = 1 kHz		25°C		9			9		nv/√Hz
V	Peak-to-peak equivalent input	f = 0.1 Hz to 1 Hz		25°C		1			1		
V _{NPP}	noise voltage	f = 0.1 Hz to 10 Hz		25°C		1.4			1.4		μV
In	Equivalent input noise current			25°C		0.6			0.6		fA/√ Hz
	Total harmonic	$V_0 = \pm 2.3 \text{ V}$	A _V = 1			0.0011%			0.0011%		
THD + N	distortion plus	$R_L = 10 \text{ k}\Omega$	A _V = 10	25°C		0.004%			0.004%		
	noise	f = 20 kHz	A _V = 100			0.03%			0.03%		
	Gain-bandwidth product	f = 10 kHz, C _L = 100 pF	$R_L = 10 \text{ k}\Omega$,	25°C		2.25			2.25		MHz
B _{OM}	Maximum output-swing bandwidth	$V_{O(PP)} = 4.6 \text{ V},$ $R_L = 10 \text{ k}\Omega,$	A _V = 1, C _L = 100 pF	25°C		0.54			0.54		MHz
	Cattling time	$A_V = -1$, Step = -2.3 V to 2.3 V,	To 0.1%	25°C		1.5			1.5		;
t _s	Settling time	$R_L = 10 \text{ k}\Omega$, $C_L = 100 \text{ pF}$	To 0.01%	25°C		3.2		·	3.2		μ\$
φ _m	Phase margin at unity gain	$R_{l} = 10 \text{ k}\Omega$	C _I = 100 pF	25°C		52°			52°		
	Gain margin		= *	25°C		10			10		dB

[†] Full range is –40°C to 125°C for Q level part.



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TLC2274Q electrical characteristics at specified free-air temperature, V_{DD} = 5 V (unless otherwise noted)

	PARAMETER	TEST CON	DITIONS	-+	Т	LC22740	Q	TL	.C2274A	Q	
	PANAIVIETEN	TEST CON	DITIONS	T _A †	MIN	TYP	MAX	MIN	TYP	MAX	UNIT
V _{IO}	Input offset voltage			25°C		300	2500		300	950	μV
۷IO	input onset voltage			Full range			3000			1500	μν
α_{VIO}	Temperature coefficient of input offset voltage			25°C to 125°C		2			2		μV/°C
	Input offset voltage long-term drift (see Note 4)	$V_{DD\pm} = \pm 2.5 \text{ V},$ $V_{O} = 0 \text{ V},$	$V_{IC} = 0 V$, $R_S = 50 \Omega$	25°C		0.002			0.002		μV/mo
I _{IO}	Input offset current			25°C		0.5	60		0.5	60	рA
10	input onset current]		Full range			800			800	рΑ
I _{IB}	Input bias current			25°C		1	60		1	60	pА
ıВ	input bias current			Full range			800			800	рΑ
V	Common-mode input	$R_S = 50 \Omega$,	V _{IO} ≤ 5 mV	25°C	0 to 4	-0.3 to 4.2		0 to 4	-0.3 to 4.2		٧
V _{ICR}	voltage	ns = 50 12,	v O ≥ 3111v	Full range	0 to 3.5			0 to 3.5			V
		$I_{OH} = -20 \mu A$		25°C		4.99			4.99		
		J 200 A		25°C	4.85	4.93		4.85	4.93		
V_{OH}	High-level output voltage	$I_{OH} = -200 \mu\text{A}$		Full range	4.85			4.85			V
	vollage	1 4 4		25°C	4.25	4.65		4.25	4.65		
		$I_{OH} = -1 \text{ mA}$		Full range	4.25			4.25			
		$V_{IC} = 2.5 V$,	$I_{OL} = 50 \mu\text{A}$	25°C		0.01			0.01		
	Landanal andres	V _{IC} = 2.5 V,		25°C		0.09	0.15		0.09	0.15	
V_{OL}	Low-level output voltage	$I_{OL} = 500 \mu\text{A}$		Full range			0.15			0.15	V
	voltage	V _{IC} = 2.5 V,	I _{OL} = 5 mA	25°C		0.9	1.5		0.9	1.5	
		V _{IC} = 2.5 V,	10L = 2111A	Full range			1.5			1.5	
	1	.,	D 10 kgt	25°C	10	35		10	35		
A_{VD}	Large-signal differential voltage amplification	$V_{IC} = 2.5 \text{ V},$ $V_{O} = 1 \text{ V to 4 V}$	$R_L = 10 \text{ k}\Omega^{\ddagger}$	Full range	10			10			V/mV
	voltage amplification	VO = 1 V 10 4 V	$R_L = 1 M\Omega^{\ddagger}$	25°C		175			175		
r _{id}	Differential input resistance			25°C		10 ¹²			10 ¹²		Ω
rį	Common-mode input resistance			25°C		10 ¹²			10 ¹²		Ω
Ci	Common-mode input capacitance	f = 10 kHz,	N package	25°C		8			8		pF
z _o	Closed-loop output impedance	f = 1 MHz,	A _V = 10	25°C		140			140		Ω
OMBE	Common-mode	$V_{IC} = 0 \text{ V to } 2.7 \text{ V}$	/,	25°C	70	75		70	75		45
CMRR	rejection ratio	$V_0 = 2.5 \text{ V},$	$R_S = 50 \Omega$	Full range	70			70			dB
l _k	Supply-voltage rejection	$V_{DD} = 4.4 \text{ V to } 10^{-1}$	6 V,	25°C	80	95		80	95		4D
k _{SVR}	ratio ($\Delta V_{DD}/\Delta V_{IO}$)	$V_{IC} = V_{DD}/2$,	No load	Full range	80			80			dB
_	Cumply ourrent	V = 0.5.V	Nolood	25°C		4.4	6		4.4	6	m ^
I _{DD}	Supply current	$V_{O} = 2.5 V$,	No load	Full range			6			6	mA

[†] Full range is -40°C to 125°C for Q level part.

NOTE 4: Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at $T_A = 150^{\circ}C$ extrapolated to $T_A = 25^{\circ}C$ using the Arrhenius equation and assuming an activation energy of 0.96 eV.



[‡] Referenced to 2.5 V

TLC227x-Q1, TLC227xA-Q1 Advanced LinCMOS™ RAIL-TO-RAIL **OPERATIONAL AMPLIFIERS**SGLS007D - FEBRUARY 2003 - REVISED MARCH 2009

TLC2274Q operating characteristics at specified free-air temperature, $V_{DD} = 5 \text{ V}$

	DAMETER	TEGT CONDI	TIONO	- +	1	TLC22740	2	TL	C2274A	Q	UNIT
PA	RAMETER	TEST CONDI	IIONS			MAX	MIN	TYP	MAX	UNII	
	Olassa at such	V 05V4-05V	0 400 - Ft	25°C	2.3	3.6		2.3	3.6		
SR	Slew rate at unity gain	$V_{O} = 0.5 \text{ V to } 2.5 \text{ V},$ $R_{L} = 10 \text{ k}\Omega^{\ddagger},$	C _L = 100 pF [‡]	Full range	1.7			1.7			V/µs
v	Equivalent input	f = 10 Hz		25°C		50			50		/
V _n	noise voltage	f = 1 kHz		25°C		9			9		nV/√Hz
V	Peak-to-peak	f = 0.1 Hz to 1 Hz		25°C		1			1		.,
V _{N(PP)}	equivalent input noise voltage	f = 0.1 Hz to 10 Hz		25°C		1.4			1.4		μV
In	Equivalent input noise current			25°C		0.6			0.6		fA/√ Hz
	Total harmonic	$V_0 = 0.5 \text{ V to } 2.5 \text{ V},$	A _V = 1			0.0013%			0.0013%		
THD + N	distortion plus	f = 20 kHz,	A _V = 10	25°C		0.004%		0.004%			
	noise	$R_L = 10 \text{ k}\Omega^{\ddagger}$	A _V = 100			0.03%			0.03%		
	Gain-bandwidth product	f = 10 kHz, C _L = 100 pF [‡]	$R_L = 10 \text{ k}\Omega^{\ddagger}$,	25°C		2.18			2.18		MHz
B _{OM}	Maximum out- put-swing band- width	$V_{O(PP)} = 2 \text{ V},$ $R_L = 10 \text{ k}\Omega^{\ddagger},$	$A_V = 1$, $C_L = 100 \text{ pF}^{\ddagger}$	25°C		1			1		MHz
	O a Million at Minner	$A_V = -1$, Step = 0.5 V to 2.5 V,	To 0.1%	0500		1.5			1.5		
t _s	Settling time	$R_L = 10 \text{ k}\Omega^{\ddagger},$ $C_L = 100 \text{ pF}^{\ddagger}$	To 0.01%	25°C		2.6	_		2.6		μ\$
φ _m	Phase margin at unity gain	$R_L = 10 \text{ k}\Omega^{\ddagger}$,	C _L = 100 pF [‡]	25°C		50°			50°		
	Gain margin		- •	25°C		10			10		dB

[†] Full range is -40°C to 125°C for Q level part.



[‡] Referenced to 2.5 V

SGLS007D - FEBRUARY 2003 - REVISED MARCH 2009

TLC2274Q electrical characteristics at specified free-air temperature, $V_{DD\pm}$ = ± 5 V (unless otherwise noted)

PARAMETER		TEST CONDITIONS			TLC2274Q			TLC2274AQ			
				T _A †	MIN	TYP	MAX	MIN	TYP	MAX	UNIT
.,	loon it offerst valte as			25°C		300	2500		300	950	
V_{IO}	Input offset voltage			Full range			3000			1500	μV
α_{VIO}	Temperature coefficient of input offset voltage			25°C to 125°C		2			2		μV/°C
	Input offset voltage long- term drift (see Note 4)	$V_{IC} = 0 V$, $R_S = 50 \Omega$	$V_O = 0 V$,	25°C		0.002			0.002		μV/mo
	Input offeet ourrent			25°C		0.5	60		0.5	60	20
I _{IO}	Input offset current			Full range			800			800	рA
1	Input hige current]		25°C		1	60		1	60	4
I _{IB}	Input bias current			Full range			800			800	рA
V _{ICR}	Common-mode input	R ₂ = 50.0	V _{IO} ≤ 5 mV	25°C	-5 to 4	-5.3 to 4.2		-5 to 4	-5.3 to 4.2		· v
VICR	voltage	118 = 30 22,	V O ≥ 5 111V	Full range	-5 to 3.5			-5 to 3.5			
		$I_{O} = -20 \mu A$	$_{\text{O}} = -20 \mu\text{A}$ 25°C 4.99				4.99				
	Maximum positive peak output voltage	$I_{O} = -200 \mu\text{A}$		25°C	4.85	4.93		4.85	4.93		٧
V _{OM+}				Full range	4.85			4.85			
		I _O = -1 mA		25°C	4.25	4.65		4.25	4.65		
				Full range	4.25			4.25			
	Maximum negative peak output voltage	$V_{IC} = 0 V$,	$I_O = 50 \mu\text{A}$	25°C		-4.99			-4.99		
		$V_{IC} = 0 V,$ $V_{IC} = 0 V,$	I _O = 500 μA	25°C	-4.85	-4.91		-4.85	-4.91		V
V_{OM-}				Full range	-4.85			-4.85			
	output rollago			25°C	-3.5	-4.1		-3.5	-4.1		
			10 = 2 IIIA	Full range	-3.5			-3.5			
	Large-signal differential voltage amplification		B = 10 kO	25°C	20	50		20	50		
A_{VD}		$V_O = \pm 4 \text{ V}$	$R_L = 10 \text{ k}\Omega$	Full range	20			20			V/mV
			$R_L = 1 M\Omega$	25°C		300			300		
r _{id}	Differential input resistance			25°C		10 ¹²			10 ¹²		Ω
r _i	Common-mode input resistance			25°C		10 ¹²			10 ¹²		Ω
c _i	Common-mode input capacitance	f = 10 kHz,	N package	25°C		8			8		pF
Z _O	Closed-loop output impedance	f = 1 MHz,	A _V = 10	25°C		130			130		Ω
01155	Common-mode rejection	$V_{IC} = -5 \text{ V to } 2.7 \text{ V}$		25°C	75	80		75	80		-ID
CMRR	ratio	$V_O = 0 V$,	$R_S = 50 \Omega$	Full range	75			75			dB
	Supply-voltage rejection	$V_{DD\pm} = \pm 2$.	.2 V to ±8 V, No load	25°C	80	95		80	95		-ID
k _{SVR}	ratio $(\Delta V_{DD\pm}/\Delta V_{IO})$	$V_{IC} = 0 V$		Full range	80			80			dB
1	Supply current	V _O = 0 V,	No load	25°C		4.8	6		4.8	6	mA
I _{DD}	очрріу сипепі	ν _O = υ ν,	No load	Full range			6			6	I IIIA

[†] Full range is –40°C to 125°C for Q level part.

NOTE 4: Typical values are based on the input offset voltage shift observed through 168 hours of operating life test at $T_A = 150^{\circ}$ C extrapolated to $T_A = 25^{\circ}$ C using the Arrhenius equation and assuming an activation energy of 0.96 eV.



TLC227x-Q1, TLC227xA-Q1 Advanced LinCMOS™ RAIL-TO-RAIL **OPERATIONAL AMPLIFIERS**SGLS007D - FEBRUARY 2003 - REVISED MARCH 2009

TLC2274Q operating characteristics at specified free-air temperature, $V_{DD\pm}$ = $\pm 5~V$

	ADAMETED	TEST COMPITIONS		+ +	TLC2274Q			TLC2274AQ			UNIT	
PARAMETER		TEST CONDITION	T _A †	MIN	TYP	MAX	MIN	TYP	MAX	UNII		
				25°C	2.3	3.6		2.3	3.6			
SR	Slew rate at unity gain	$V_{O} = \pm 2.3 \text{ V},$ $C_{L} = 100 \text{ pF}$	= 10 kΩ,	Full range	1.7			1.7			V/μs	
V	Equivalent input noise voltage	f = 10 Hz f = 1 kHz		25°C		50			50		nV/√ Hz	
V _n				25°C		9			9			
V	Peak-to-peak equivalent input noise voltage	f = 0.1 Hz to 1 Hz	25°C		1			1				
V _{N(PP)}		f = 0.1 Hz to 10 Hz	25°C		1.4			1.4		μ V		
In	Equivalent input noise current			25°C		0.6			0.6		fA/√ Hz	
	Total harmonic distortion plus	$V_0 = \pm 2.3 \text{ V},$	$A_V = 1$	25°C		0.0011%			0.0011%			
THD + N		$R_L = 10 \text{ k}\Omega$	A _V = 10			0.004%			0.004%			
	noise	f = 20 kHz	A _V = 100		0.03%			0.03%				
	Gain-bandwidth product	$f = 10 \text{ kHz}, \qquad \qquad R_L$ $C_L = 100 \text{ pF}$	= 10 kΩ,	25°C		2.25			2.25		MHz	
B _{OM}	Maximum output-swing bandwidth	$V_{O(PP)} = 4.6 \text{ V}, \qquad A_V \\ R_L = 10 \text{ k}\Omega, \qquad C_L$	= 1, = 100 pF	25°C		0.54			0.54		MHz	
t _s	Settling time	$A_V = -1$, Step = -2.3 V to 2.3 V, $R_L = 10 \text{ k}\Omega$, $C_L = 100 \text{ pF}$	To 0.1%	25°C		1.5			1.5			
			To 0.01%	25°C		3.2			3.2		μ\$	
φ _m	Phase margin at unit gain	$R_L = 10 \text{ k}\Omega, \qquad C_L$	= 100 pF	25°C		52°			52°			
	Gain margin	<u> </u>	•	25°C		10			10		dB	

[†] Full range is –40°C to 125°C for Q level part.



Table of Graphs

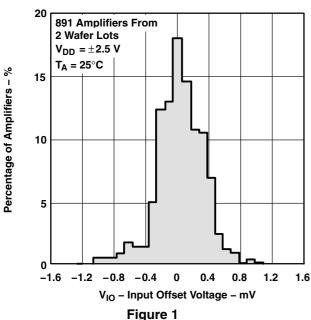
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NOTE: For all graphs where $V_{DD} = 5 \text{ V}$, all loads are referenced to 2.5 V.



Percentage of Amplifiers - %

DISTRIBUTION OF TLC2272 INPUT OFFSET VOLTAGE



DISTRIBUTION OF TLC2272 INPUT OFFSET VOLTAGE

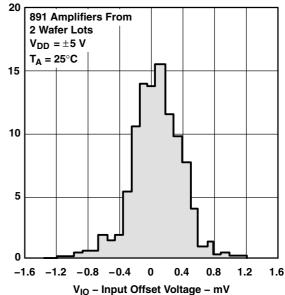


Figure 2

DISTRIBUTION OF TLC2274 INPUT OFFSET VOLTAGE

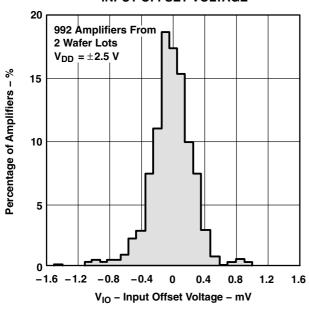


Figure 3

DISTRIBUTION OF TLC2274 INPUT OFFSET VOLTAGE

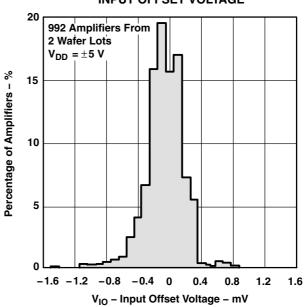


Figure 4



INPUT OFFSET VOLTAGE

TYPICAL CHARACTERISTICS

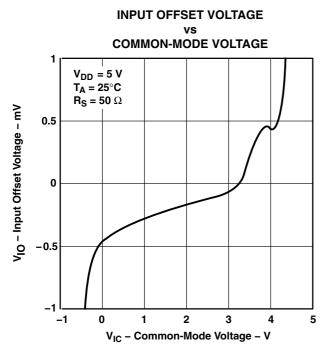


Figure 5

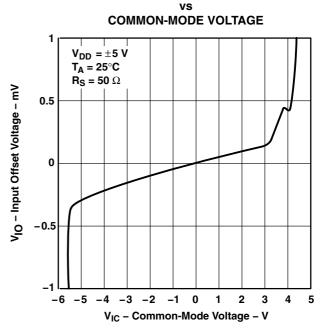


Figure 6

DISTRIBUTION OF TLC2272 vs INPUT OFFSET VOLTAGE TEMPERATURE COEFFICIENT†

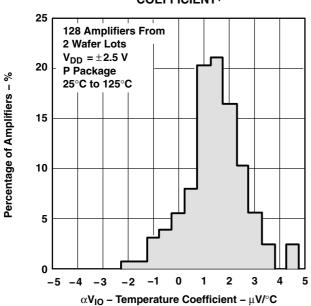


Figure 7

DISTRIBUTION OF TLC2272 vs INPUT OFFSET VOLTAGE TEMPERATURE COEFFICIENT†

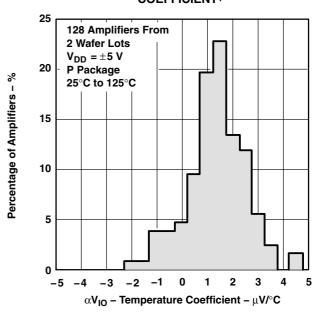
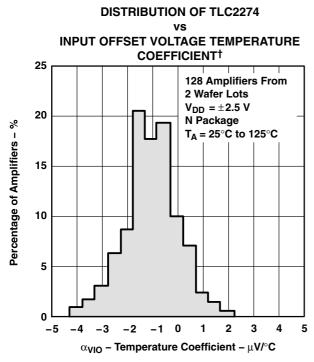


Figure 8

[†] Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.



25



2 Wafer Lots $V_{DD} = \pm 2.5 V$ 20 N Package Percentage of Amplifiers - % $T_A = 25^{\circ}C$ to $125^{\circ}C$ 15 10 5 -5

DISTRIBUTION OF TLC2274

INPUT OFFSET VOLTAGE TEMPERATURE

COEFFICIENT[†]

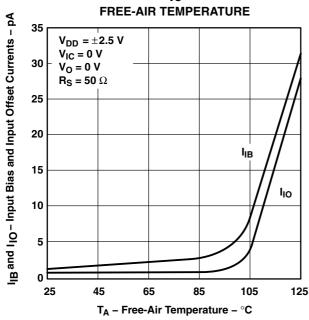
128 Amplifiers From

Figure 9

Figure 10

 α_{VIO} – Temperature Coefficient – $\mu\text{V}/^{\circ}\text{C}$





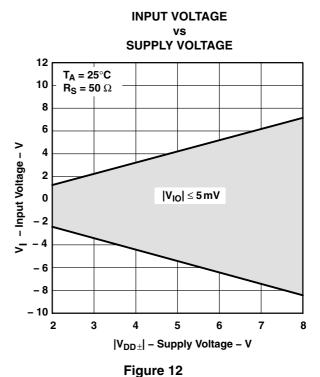


Figure 11

[†] Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.



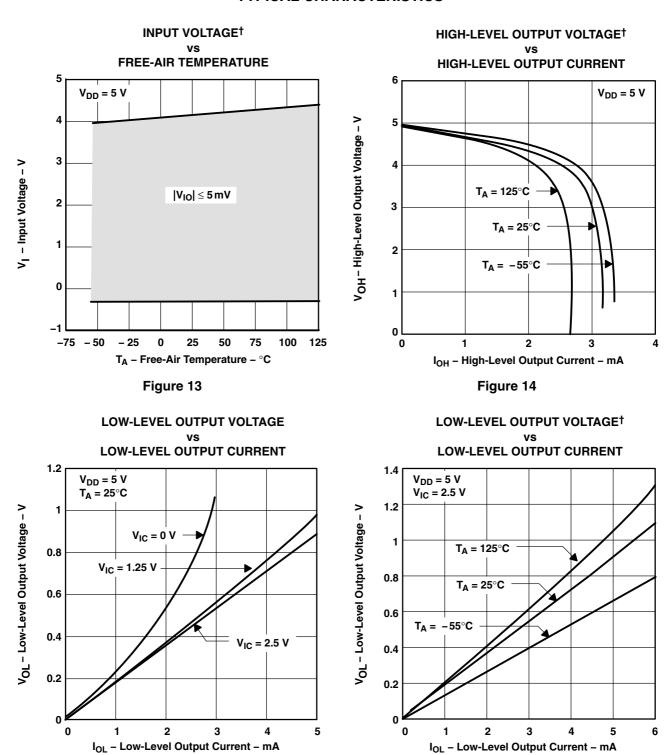


Figure 15



Figure 16

[†] Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

MAXIMUM POSITIVE PEAK OUTPUT VOLTAGE† **OUTPUT CURRENT** V_{OM+} - Maximum Positive Peak Output Voltage - V $V_{DD}\pm=\pm5~V$ $T_A = -55^{\circ}C$ T_A = 25°C $T_A = 125^{\circ}C$ 0 3 |IO| - Output Current - mA

MAXIMUM NEGATIVE PEAK OUTPUT VOLTAGE†

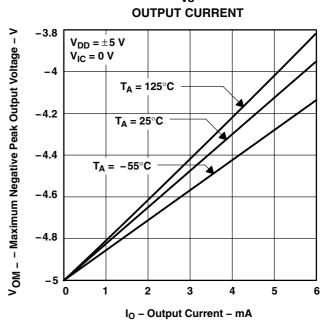
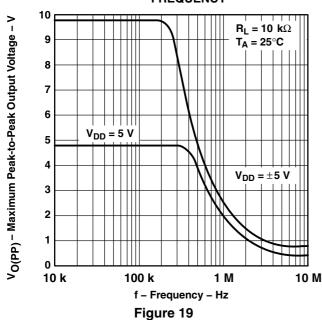


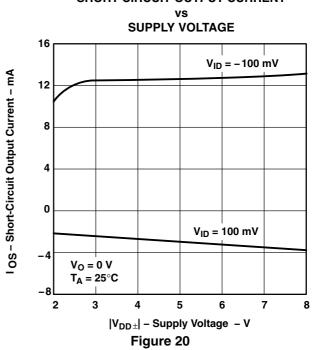
Figure 18







SHORT-CIRCUIT OUTPUT CURRENT



[†] Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.



SHORT-CIRCUIT OUTPUT CURRENT† FREE-AIR TEMPERATURE 15 **V**O = 0 **V** $V_{DD} = \pm 5 \text{ V}$ OS - Short-Circuit Output Current - mA $V_{ID} = -100 \text{ mV}$ 11 7 -3 $V_{ID} = 100 \text{ mV}$ -75 -50 -25 0 25 50 75 100 125 T_A - Free-Air Temperature - °C

Figure 21

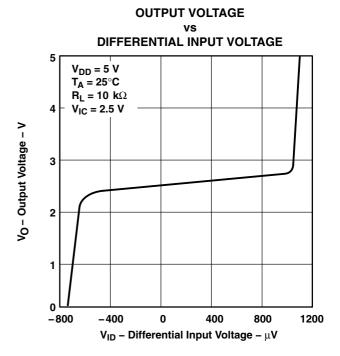
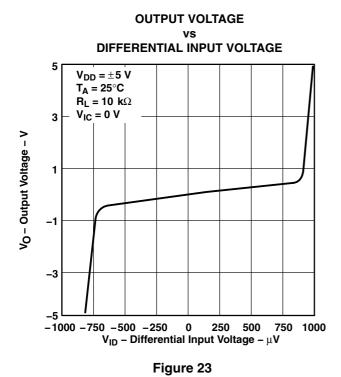


Figure 22

LARGE-SIGNAL DIFFERENTIAL

VOLTAGE AMPLIFICATION



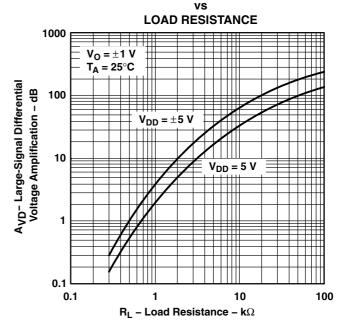


Figure 24

[†] Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.



LARGE-SIGNAL DIFFERENTIAL VOLTAGE AMPLIFICATION AND PHASE MARGIN

FREQUENCY 80 180° $V_{DD} = 5 V$ $R_L = 10 \text{ k}\Omega$ $C_{L}^{-} = 100 \text{ pF}$ 135° 60 $T_A = 25^{\circ}C$ A_{VD}- Large-Signal Differential Voltage Amplification - dB 40 90° [♦]m - Phase Margin 45° 20 **0**° 0 -20 -45° -90° -40 1 k 10 k 100 k 1 M 10 M

Figure 25

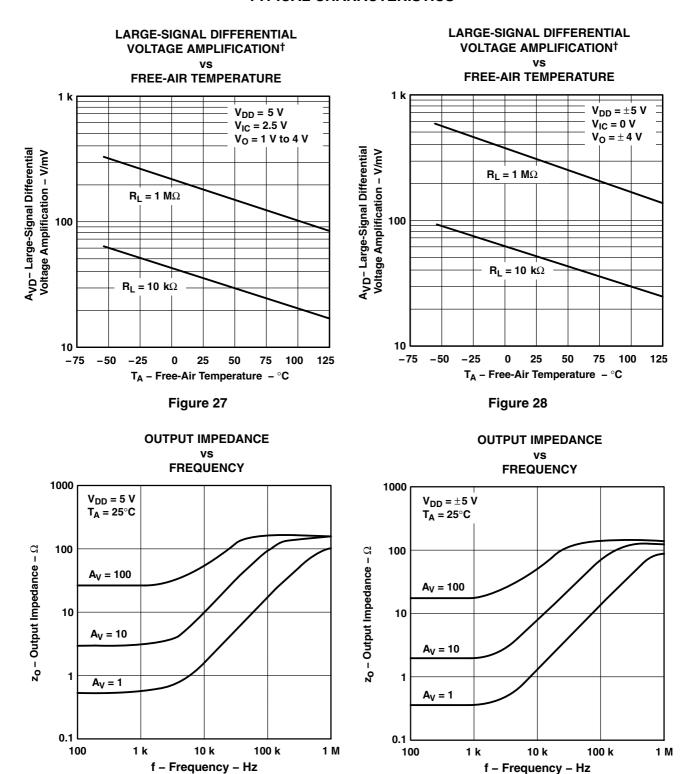
f - Frequency - Hz

LARGE-SIGNAL DIFFERENTIAL VOLTAGE AMPLIFICATION AND PHASE MARGIN

FREQUENCY 80 180° V_{DD} = $\pm 5~V$ $R_L = 10 \text{ k}\Omega$ $C_{L}^{-} = 100 \text{ pF}$ 135° 60 T_A = 25°C A_{VD}- Large-Signal Differential Voltage Amplification - dB ⁶m − Phase Margin 90° 40 45° 20 **0**° 0 -20 -45° -90° 1 k 10 k 100 k 10 M f - Frequency - Hz

Figure 26





[†] Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

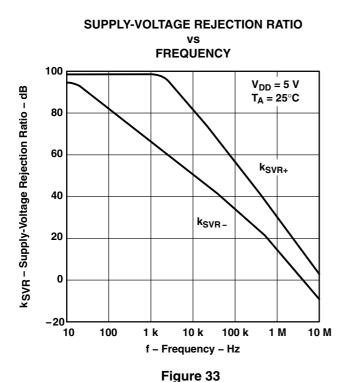
Figure 29



Figure 30

COMMON-MODE REJECTION RATIO FREQUENCY 100 $T_A = 25^{\circ}C$ CMRR - Common-Mode Rejection Ratio - dB $V_{DD} = \pm 5 V$ 80 $V_{DD} = 5 V$ 60 40 20 10 100 1 k 10 k 100 k 1 M 10 M f - Frequency - Hz

Figure 31



COMMON-MODE REJECTION RATIO vs

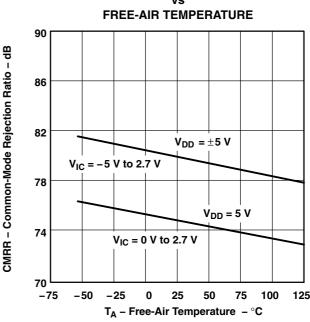


Figure 32

SUPPLY-VOLTAGE REJECTION RATIO

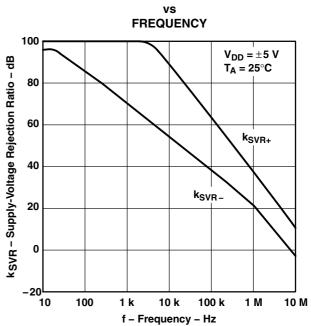


Figure 34



TLC2272

TYPICAL CHARACTERISTICS

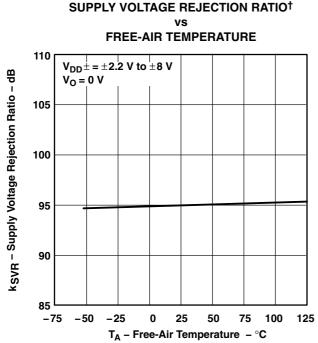
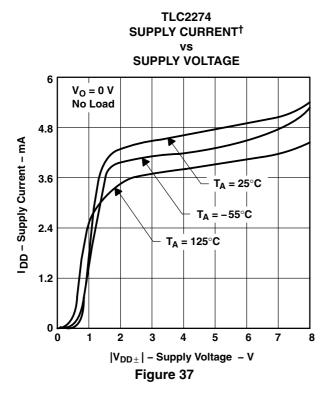


Figure 35



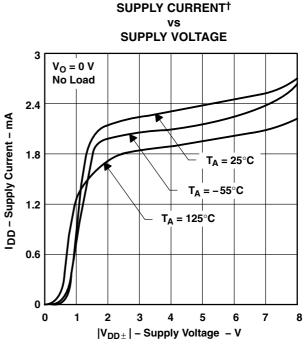
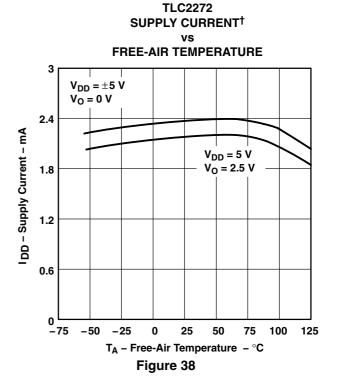
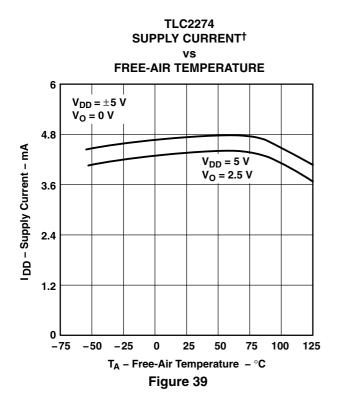


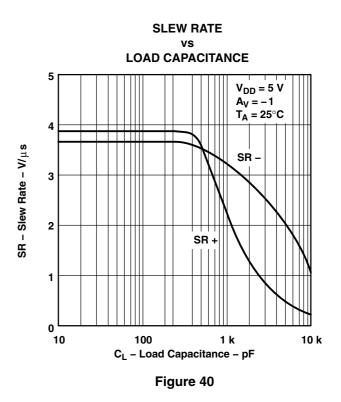
Figure 36



[†] Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.

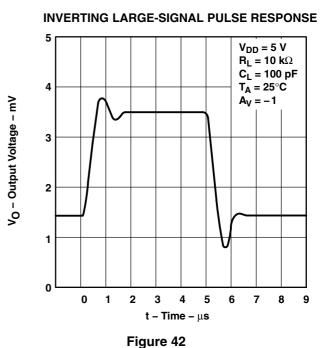






SLEW RATE[†] FREE-AIR TEMPERATURE 5 SR -SR – Slew Rate – V/μs SR+ 3 $V_{DD} = 5 V$ $R_L = 10 \text{ k}\Omega$ $C_{L} = 100 pF$ $A_V = 1$ -75 -50 -25 0 25 50 75 100 125 T_A – Free-Air Temperature – $^{\circ}C$

Figure 41



† Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.



INVERTING LARGE-SIGNAL PULSE RESPONSE

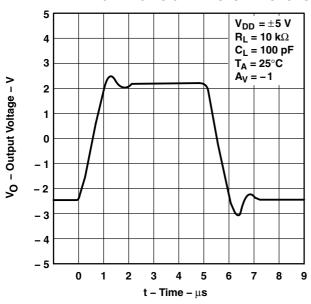


Figure 43

VOLTAGE-FOLLOWER LARGE-SIGNAL PULSE RESPONSE

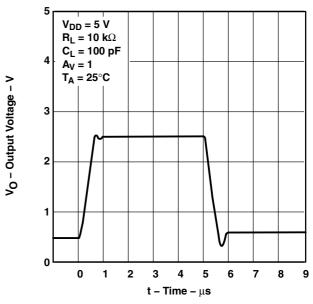


Figure 44

VOLTAGE-FOLLOWER LARGE-SIGNAL PULSE RESPONSE

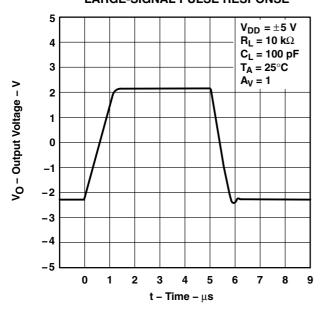


Figure 45

INVERTING SMALL-SIGNAL PULSE RESPONSE

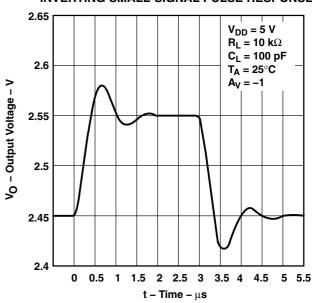


Figure 46

INVERTING SMALL-SIGNAL PULSE RESPONSE

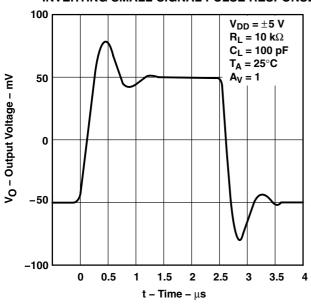


Figure 47

VOLTAGE-FOLLOWER SMALL-SIGNAL PULSE RESPONSE

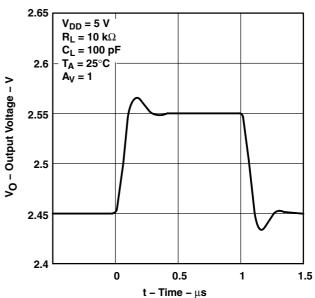


Figure 48

VOLTAGE-FOLLOWER SMALL-SIGNAL PULSE RESPONSE

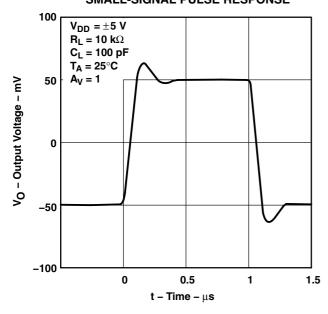


Figure 49

EQUIVALENT INPUT NOISE VOLTAGE

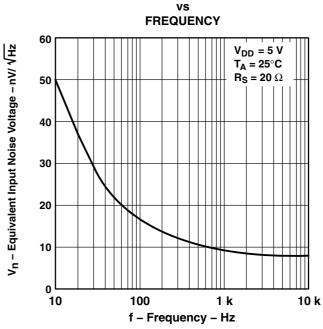


Figure 50

EQUIVALENT INPUT NOISE VOLTAGE

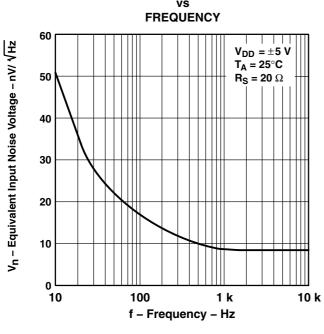


Figure 51

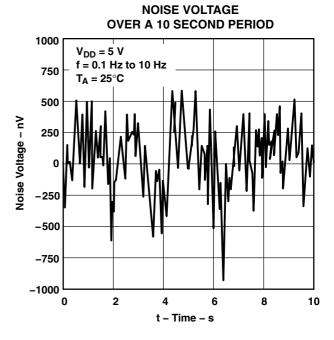


Figure 52

INTEGRATED NOISE VOLTAGE

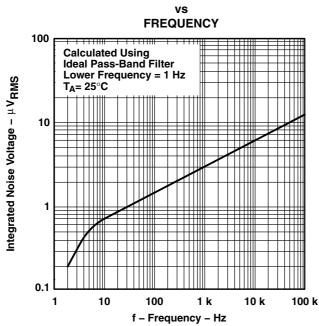


Figure 53

TOTAL HARMONIC DISTORTION PLUS NOISE

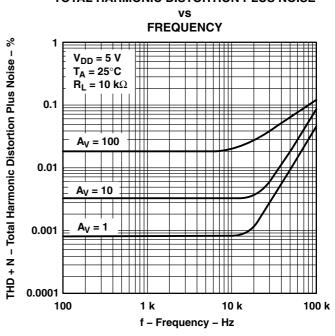
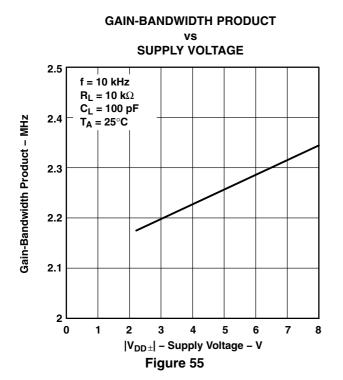
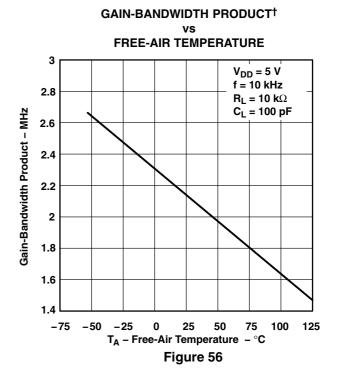
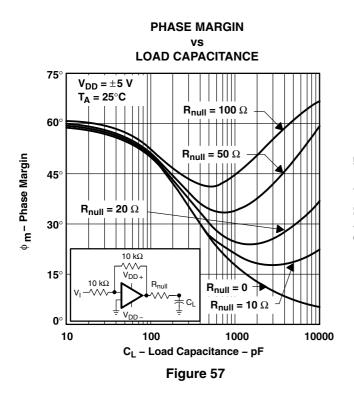


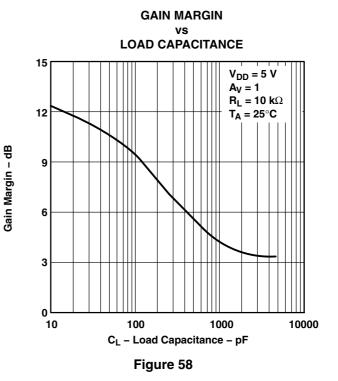
Figure 54











[†] Data at high and low temperatures are applicable only within the rated operating free-air temperature ranges of the various devices.



SGLS007D - FEBRUARY 2003 - REVISED MARCH 2009

APPLICATION INFORMATION

macromodel information

Macromodel information provided was derived using Microsim $Parts^{TM}$, the model generation software used with Microsim $PSpice^{TM}$. The Boyle macromodel (see Note 5) and subcircuit in Figure 59 were generated using the TLC227x typical electrical and operating characteristics at $T_A = 25^{\circ}C$. Using this information, output simulations of the following key parameters can be generated to a tolerance of 20% (in most cases):

- Maximum positive output voltage swing
- Maximum negative output voltage swing
- Slew rate
- Quiescent power dissipation
- Input bias current
- Open-loop voltage amplification

- Unity gain frequency
- Common-mode rejection ratio
- Phase margin
- DC output resistance
- AC output resistance
- Short-circuit output current limit

NOTE 5: G. R. Boyle, B. M. Cohn, D. O. Pederson, and J. E. Solomon, "Macromodeling of Integrated Circuit Operational Amplifiers", *IEEE Journal of Solid-State Circuits*, SC-9, 353 (1974).

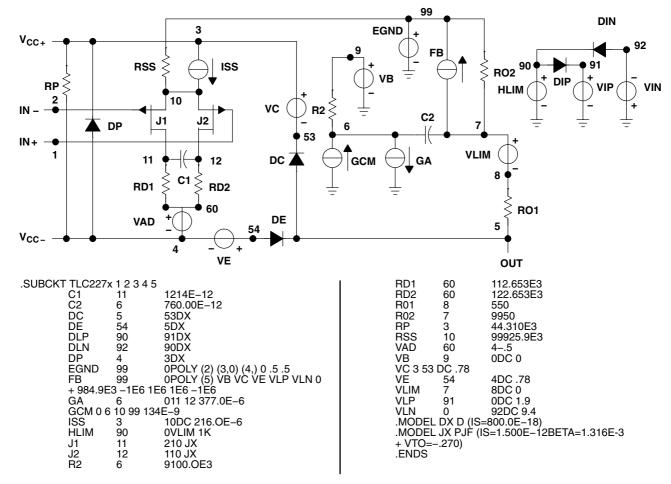


Figure 59. Boyle Macromodel and Subcircuit

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PACKAGE OPTION ADDENDUM

www.ti.com 7-May-2010

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	e Eco Plan ⁽²⁾	Lead/Ball Finish	MSL Peak Temp ⁽³⁾
TLC2272AQDRG4Q1	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
TLC2272AQDRQ1	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
TLC2272AQPWRG4Q1	ACTIVE	TSSOP	PW	8	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
TLC2272AQPWRQ1	ACTIVE	TSSOP	PW	8	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
TLC2272QDRG4Q1	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
TLC2272QDRQ1	ACTIVE	SOIC	D	8	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
TLC2272QPWRG4Q1	ACTIVE	TSSOP	PW	8	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
TLC2272QPWRQ1	ACTIVE	TSSOP	PW	8	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
TLC2274AQDRG4Q1	ACTIVE	SOIC	D	14	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
TLC2274AQDRQ1	ACTIVE	SOIC	D	14	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
TLC2274AQPWRG4Q1	ACTIVE	TSSOP	PW	14	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
TLC2274AQPWRQ1	ACTIVE	TSSOP	PW	14	2000	TBD	CU NIPDAU	Level-1-250C-UNLIM
TLC2274QDRG4Q1	ACTIVE	SOIC	D	14	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
TLC2274QDRQ1	ACTIVE	SOIC	D	14	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
TLC2274QPWRG4Q1	ACTIVE	TSSOP	PW	14	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
TLC2274QPWRQ1	ACTIVE	TSSOP	PW	14	2000	TBD	CU NIPDAU	Level-1-250C-UNLIM

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

⁽²⁾ Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

⁽³⁾ MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.



PACKAGE OPTION ADDENDUM

www.ti.com 7-May-2010

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In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

OTHER QUALIFIED VERSIONS OF TLC2272-Q1, TLC2272A-Q1, TLC2274-Q1, TLC2274A-Q1:

- Catalog: TLC2272, TLC2272A, TLC2274, TLC2274A
- Enhanced Product: TLC2272A-EP, TLC2274-EP, TLC2274A-EP
 Military: TLC2272M, TLC2272AM, TLC2274AM

NOTE: Qualified Version Definitions:

- Catalog TI's standard catalog product
- Enhanced Product Supports Defense, Aerospace and Medical Applications
- Military QML certified for Military and Defense Applications

D (R-PDSO-G14)

PLASTIC SMALL-OUTLINE PACKAGE

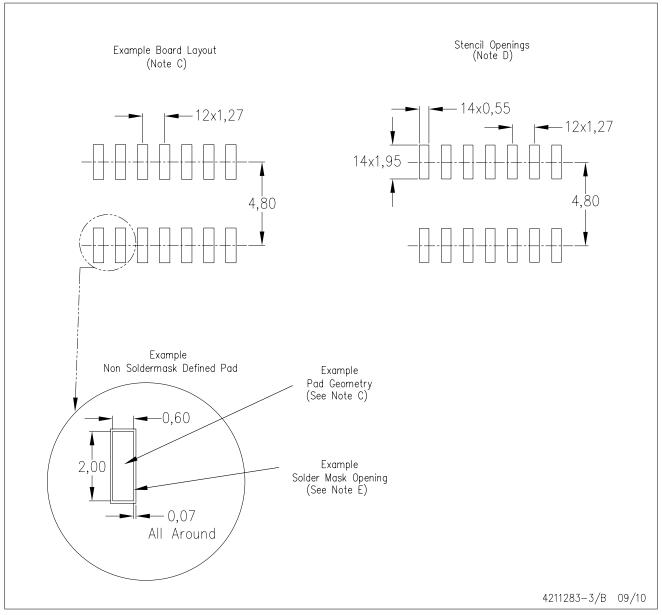


- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed .006 (0,15) per end.
- Body width does not include interlead flash. Interlead flash shall not exceed .017 (0,43) per side.
- E. Reference JEDEC MS-012 variation AB.



D (R-PDSO-G14)

PLASTIC SMALL OUTLINE



- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



D (R-PDSO-G8)

PLASTIC SMALL-OUTLINE PACKAGE

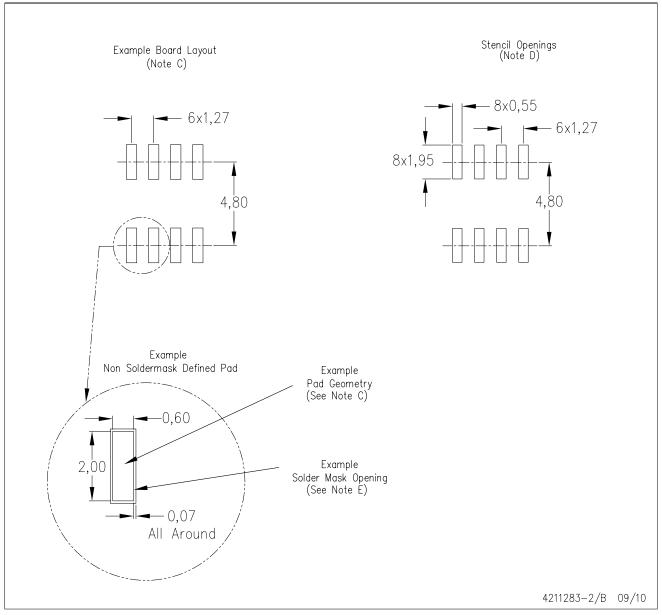


- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed .006 (0,15) per end.
- Body width does not include interlead flash. Interlead flash shall not exceed .017 (0,43) per side.
- E. Reference JEDEC MS-012 variation AA.



D (R-PDSO-G8)

PLASTIC SMALL OUTLINE



- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



PW (R-PDSO-G**)

14 PINS SHOWN

PLASTIC SMALL-OUTLINE PACKAGE



NOTES: A. All linear dimensions are in millimeters.

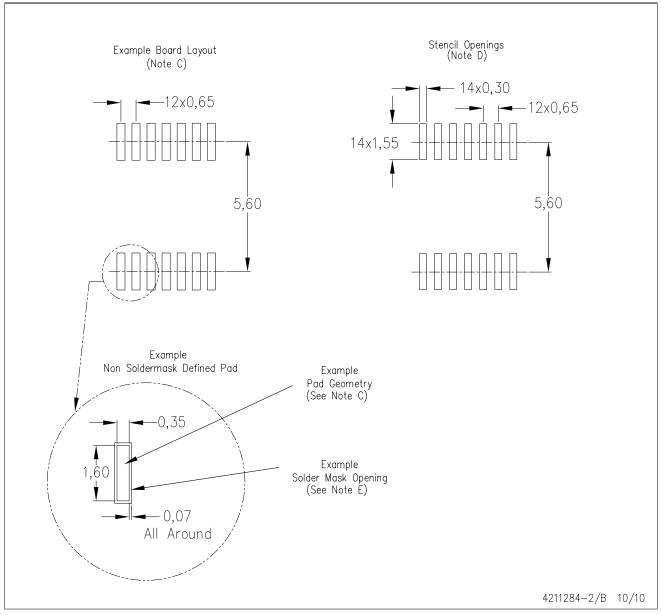
B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0,15.

D. Falls within JEDEC MO-153

PW (R-PDSO-G14)

PLASTIC SMALL OUTLINE



- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



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		Wireless	www.ti.com/wireless-apps		